M odeling inelastic phonon scattering in atom ic- and m olecular-w ire junctions

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C om putationally inexpensive approximations describing electron-phonon scattering in molecularscale conductors are derived from the non-equilibrium G men's function method. The accuracy is demonstrated with a rst principles calculation on an atom ic gold wire. Quantitative agreement between the full non-equilibrium G men's function calculation and the new ly derived expressions is obtained while simplifying the computational burden by several orders of magnitude. In addition, analytical models provide intuitive understanding of the conductance including non-equilibrium heating and provide a convenient way of parameterizing the physics. This is exemplied by tting the expressions to the experimentally observed conductances through both an atom ic gold wire and a hydrogen molecule.

The rapid evolution in electronics tow ards sm aller and faster devices will eventually reach the fundam ental level set by the atom istic structure of matter. A tom ic-size conductors take this developm ent to the extrem e of m in iaturization [1], and understanding their properties is an important problem in the emerging elds of nanoelectronics and molecular electronics. One relevant aspect is the study of the e ects caused by atom ic vibrations, since inelastic scattering of traversing electrons and energy dissipation play essential roles for device characteristics, working conditions, and stability. V ibrational signals can also be used to extract inform ation about the detailed m icroscopic con guration, which usually cannot be in aged simultaneously with a transport measurement. Inelastic e ects have in the recent years been studied in a variety of nanoscale system s, e.g., single m olecules on surfaces probed with the scanning tunneling microscope (STM) [2], m olecules in break junctions [3], and m etallic atom ic wires [4].

Theoretical descriptions of inelastic transport through small devices connected to metallic contacts include many-body theory in the Coulomb blockade regime [5], single-particle rst-order perturbation approaches [6, 7], i.e., \Ferm i's golden rule" (FGR), as well as calculations to in nite order based on the self-consistent Born approximation (SCBA) combined with non-equilibrium G reen's functions (NEGF) [8, 9, 10]. Our work is based on the SCBA, which in contrast to FGR takes the manyparticle nature of the problem into account. How ever, the SCBA method is computationally very demanding especially when used in combination with rst principles electronic structure methods. Moreover, the SCBA does not yield simple form ulas which can be used to extract inform ation from experimental data.

In this paper we develop m ethods which vastly sim plify the SCBA approach. The main results are analytical formulas for the current and power derived from a lowest order expansion (LOE) of the SCBA expressions. In particular, we show how rst principles SCBA calculations on atom ic gold wires can be accurately described by the LOE with minimal computational e ort. Moreover, we derive compact analytical expressions using two simple models. These latter models are able to tboth the theoretical SCBA results as well as experiments using the electron-hole damping rate of the phonon as the central param eter [11].

Phonon scattering is included in the SCBA m ethod as self-energies to the electronic description. W e use the undam ped phonon G reen's functions to express these selfenergies in the device subspace as $[12, 13]^{1}$:

$$_{ph}^{7}(E) = \stackrel{X \quad h}{M} (n + 1)G^{7}(E \sim !) +$$

+ $n G^{7}(E \sim !)M;$ (1)

$${}^{r}_{ph}(E) = \frac{1}{2} {}^{>}_{ph}(E) {}^{<}_{ph}(E)$$

$$\frac{i}{2} H {}^{n}_{ph}(E^{0}) {}^{<}_{ph}(E^{0}) {}^{\circ}_{ph}(E^{0}) {}^{\circ}_{ph}(E^{0})$$

Here, M is the electron-phonon coupling matrix for phonon mode occupied by n phonons with energy ~!. The lesser/greater self-energy matrices $^{7}_{\rm ph}$ are given by two terms corresponding to absorption/emission of phonon quanta. We furthermore assume that these self-energies can be used in non-equilibrium with a bias dependent phonon occupation number n (V). The retarded self-energy can then be obtained from the greater/lesser parts using the Hilbert transform (H ff (E⁰)g (E) = 1 = P f (E⁰) = (E E⁰) dE⁰).

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¹ The polaron term [17] in the retarded self-energy in Eq. (2) has been neglected since it gives no \signal" at the phonon energy. However, it gives rise to two additional terms in the expression for the current (Eq. (5)) proportional to V and V² and does not contribute to the power.

The computational di culty of solving the SCBA equations stem s from the coupling of G reen's functions in energy. C alculations usually involve a num erical energy grid which has to be ne enough to resolve the low tem – perature structure of the Ferm i function, while at the same time span a large energy range to cover phonon-energies, applied bias, and allow an accurate computation of the H ilbert transform which is nonlocal in energy. The current and power are then computed as integrals over this energy grid [9, 12, 13].

These di culties can be overcom e if (i) the electronphonon coupling is weak, i.e., the probability for multiphonon processes is low, and (ii) the density of states $(D \circ S)$ of the contacts and the device is slow ly varying

over a few phonon-energies around the Ferm i energy $\mathrm{E}_{\,\mathrm{F}}$, i.e., in the notation used below, $G^{r}(E)$ $G^{r}(E_{F})$ and $_{1,2} \times _{\rm F}$). These approximations are valid 1;2(E) for systems where (i) the electron spends a short time com pared to the phonon scattering time in the device and (ii) the closest resonance energy ($E_{\rm res}$) is either far away from the Fermi energy $(f_{res} E_F)$;eV and ~!) or the broadening by the contacts is large (eV;~! and E_F). The expressions for the current and power ₽ res [9, 12, 13] can then be expanded to low est order (second) in the electron-phonon coupling and the integration over energy perform ed analytically. The power dissipated into the phonon system P^{LOE} can, after lengthy derivations, be written:

$$P^{LOE} = \frac{X}{\sim} \frac{(\sim!)^2}{(n_B (\sim!))} (n_B (\sim!) n) Tr[M AM A] + P(V;\sim!;T) Tr M G_1 G^{Y} M G_2 G^{Y};$$
(3)

$$P = \frac{\sim!}{\sim} \frac{\cosh \frac{eV}{kT}}{\cosh \frac{e!}{kT}} \frac{1 \coth \frac{\sim!}{2kT}}{\cos h \frac{eV}{kT}};$$
(4)

where n_B is the Bose-E instein distribution, which appears naturally from the integration of the Ferm i functions of the electrons in the contacts. Here, $G = G^r (E_F)$, $_{1;2} = _{1;2} (E_F)$, and $A = i(G \quad G^y)$ are the non-interacting, i.e., without phonon interactions, retarded G reen's function, the broadening by the contacts, and spectral function at E_F , respectively.

From Eq. (3) we see that the power can be decom – posed into term s corresponding to the individual phonon modes. We also note that the rst term describes the

power balance between the electron and phonon systems (at zero bias) with an electron-hole damping rate _{eh} = ! = Tr M AM A] and is in fact equivalent to the FGR expression [11, 14]. The second term is even in bias and gives the phonon absorption/em ission at nonequilibrium; it is negligible at low bias (eV ~!), turns on at the phonon energy and becomes linear in voltage at high bias (eV ~!).

U sing the same approximations, the current through the device I^{LOE} is given by [15]:

$$I^{\text{LOE}} = \frac{e^2 V}{\tilde{X}} \text{Tr } G_{2} G^{Y}_{1}$$

$$+ \overset{X}{I}^{\text{Sym}} (V; \sim !; T; n) \text{Tr } G^{Y}_{1} G M G_{2} G^{Y} M + \frac{i}{2}_{2} G^{Y} M A M hc:$$

$$X$$

+
$$I^{A \text{ sym}}(V; \sim !; T) Tr G_{1}^{Y} G_{2}^{Y} G_{2}^{Y} M G_{2}(2) G^{Y} M + h :;$$
 (5)

$$I^{Sym} = \frac{e}{\sim} 2eVn + \frac{\sim! eV}{e^{\frac{-! eV}{kT}} 1} \frac{\sim! + eV}{e^{\frac{-! + eV}{kT}} 1};$$
(6)

$$I^{A \text{ sym}} = \frac{e}{2 \sim} \left[n_{F} (E) n_{F} (E eV) \right] H f n_{F} (E^{0} + \sim!) n_{F} (E^{0} \sim!) g (E) dE;$$
(7)

where n_F is the Fermi function, the bias is de ned via, eV = 2, and the conductance quantum $G_0 = e^2 = -2$

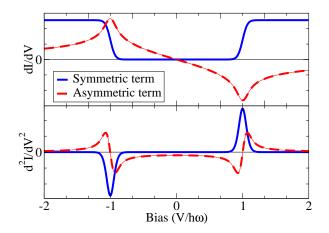


FIG. 1: Universal functions (Eqs. (6) and (7)) giving the phonon contribution to the current. The di erential conductance dI=dV and the second derivative signals is shown for one phonon m ode with the bias in units of the phonon energy at a tem perature $kT = 0.025 \sim !$. For the symmetric term, the FW HM of the second derivative peak is approximately 5.4 kT [18].

appears naturally. In contrast to the 1st order B om approximation, these expressions are current conserving like SCBA .

The current expression retains the structure of the Landauer expression (rst term of Eq. (5)) and gives correction terms for each phonon mode. The phonon terms can in turn be divided into a \symmetric" term I^{Sym} where the di erential conductance dI=dV is even in bias, and an \asymmetric" term containing the Hilbert transform I^{A sym} yielding an odd contribution. W e note the simple factorization into terms depending on the electronic structure at E_F and universal functions I^{Sym} and I^{A sym} which yield the line-shape of the inelastic signals in the I V, see Fig. 1. W hether the conductance increases or decreases due to phonon scattering depends on the sign of the traces in Eq. (5) and will be discussed further below. Exam ination of the $\$ m etric" term in Eq. (5) shows that it is zero for sym metric system s. A lthough experim entally m easured conductances contain asymmetric signals, the size of these signal is usually sm all in the published curves. At present it is unclear if they are caused by phonons or other e ects.

As we have shown previously heating of the phonon system should be considered [9] which makes the number of phonons n bias dependent. The simplest way to include non-equilibrium heating is to write down a rate equation, including an external damping rate $_{\rm d}$ of the phonons:

$$\underline{n} = \frac{P^{\text{LOE}}}{\sim !} + _{d} (n_{\text{B}} (\sim !) n); \qquad (8)$$

where P^{LOE} is the power dissipated into the individual

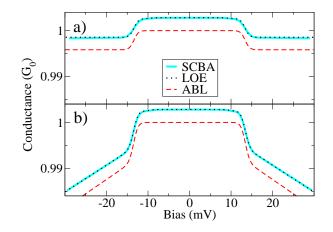


FIG.2: C om parison between the SCBA results and the LOE expressions (Eq. (5)) without heating a) and with heating b) ($_{\rm d}$ = 0) at T = 42K. The parameters for the ABL model (Eq. (12)) were extracted directly from the DFT calculations, $_{\rm eh}$ = 5:4 10¹⁰ s¹ and ~! = 13:4 m eV.

phonon m odes 2 . The steady state occupation n is easily found. Substituting the result into Eqs. (5)-(7) gives a computationally simple but powerful form ula for the current through the device including heating of the phonon system.

To judge the accuracy of the LOE approach, we com pare the LOE results to the full SCBA solution for a four atom gold wire, see Fig. 2. The SCBA calculation was perform ed as described previously [9], where the Ham iltonian, phonon modes, and electron-phonon interaction were obtained from density functional calculations (DFT). The excellent agreem ent between the full SCBA and the LOE expression can be understood by noting that the DOS of a gold wire is slow ly changing over an energy range much greater than the phonon energies. In addition, the electrons only spend a sm all time in the wire [6] com pared to the electron-hole dam ping rate. Im portantly, the LOE conductance calculations were perform ed in less than a m inute on a regular PC, com pared to severalhours for the SCBA calculations. The LOE approach thus opens up the possibility to study inelastic scattering with rst principles methods for large system s, e.g., organic molecules.

To gain further insight into the expressions presented above, we consider a single electronic site with sym m etric contacts = $_1 = _2$ coupled to one phonon m ode. Introducing the transm ission probability = $3G \int_2^2 \int_2^2$ and the electron-hole damping rate $_{\rm eh} = 4(! =)M^{-2} \int_2^2 \int_2^2$,

² For weak electron-phonon interaction, the division of power into the individual phonon m odes is straightforward from Eq. (3).

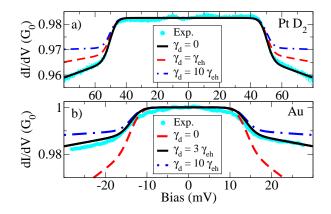


FIG. 3: a) Single level model (Eqs. (9-10)) tted to the experim entally measured conductance through a D euterium molecule [16]. The parameters used for the t are ~! = 50 meV, = 0:9825, _{eh} = 1:1 10^{12} s^{-1} , and T = 17 K. b) The ABL model (Eqs. (11-12)) tted to the measured conductance through an atom ic gold wire (experimental data from Ref. [4]). The t reveals the following parameters, ~! = 13.8 meV, T = 10 K, _{eh} = $12 \ 10^{10} \text{ s}^{-1}$, and _d = 3 eh.

we obtain:

$$P_{one}^{LOE} = e_h \sim ! (n_B (\sim !) n) + \frac{e_h}{4} \frac{\sim}{\sim !} P;$$
 (9)

$$I_{one}^{LOE} = \frac{e^2}{\sim} V + e_{eh} \frac{1}{4} \frac{2}{e^{-1}} I^{Sym} : \quad (10)$$

W e note that, from the term 1 2 in Eq. (10), the conductance will increase due to phonon scattering for low conductance systems (< 1=2) and decrease for highly conducting systems (> 1=2). The LOE approach directly provides the sign of the conductance change in contrast to FGR approaches where this requires careful considerations [6, 7].

The conductance through a single hydrogen m olecule has been m easured using a platinum break junction setup [3, 16]. Because the elastic current is carried through a single m olecular orbital [16], the single level m odel ts the experiment very well, see Fig. 3a. The best t is obtained using a negligible external dam ping of the phonon m ode ($_{d}$ ____eh) which can be understood physically from the m ass di erence between the hydrogen m olecule and the platinum atom s of the break junction. W e also note that both the size of the conductance step and the conductance slope (caused by heating) is tted with only one parameter, the electron-hole dam ping rate __eh.

The electronic structure of atom ic gold chains are qualitatively dierent from the one level model. However, it is relatively straightforward to derive an alternating bond length (ABL) model. Inserting the electron-phonon matrix for an ABL phonon mode [9] and using the G reen's function for a half led perfectly transmitting 1-D chain we obtain:

$$P_{ABL}^{LOE} = {}_{eh} \sim ! [n_B (\sim !) n] + \frac{eh}{2} \frac{n}{2} P;$$
 (11)

$$I_{ABL}^{LOE} = \frac{e^2}{\sim} V \qquad \frac{e_{eh}}{2} \frac{\sim}{e^{\sim}!} I^{Sym}; \qquad (12)$$

where the only di erence to the one-level model is that = 1 (perfect transm ission) and a factor of two caused by the absence of forward scattering from an ABL mode (the one-levelm odel has an equal am ount of forw ard and back scattering). The ABL m odel is shown in Fig. 2, with the $_{\rm eh}$ damping rate calculated directly from the DFT m odel. Them ain di erence com pared to the SCBA/LOE results is the assumption of perfect transmission through the chain. Fitting the ABL model to experim ental data [4] gives the very satisfactory t shown in Fig. 3b. We brie y note that the external dam ping $_d = 3_{eh}$ is not negligible in contrast to the hydrogen case. In this paper we have used sharp phonon energies, c.f., Eq. (2). However, if the phonon spectral function is known, it is possible to introduce broadening directly into Eqs. (3)-(7) from a nite phonon lifetime.

We have derived simple and accurate approximations to describe the e ect of phonon scattering on the conductance through nanoscale conductors. The approximate expressions greatly reduce the computationale ort, compared to solving the SCBA equations. In addition, simplem odels were derived which provide insight and are suitable to t experimental data.

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- [1] N.Agrait, A.L.Yeyati, and J.M. van Ruitenbeek, Phys. Rep. 377, 81 (2003).
- [2] B.C. Stipe, M.A. Rezaei, and W. Ho, Science 280, 1732 (1998).
- [3] R.H.M.Smit, Y.Noat, C.Untiedt, N.D.Lang, M.C. van Hemert, and J.M. van Ruitenbeek, Nature 419, 906 (2002).
- [4] N.Agrait, C.Untiedt, G.Rubio-Bollinger, and S.Vieira, Phys. Rev. Lett. 88, 216803 (2002).
- [5] S. Braig and K. Flensberg, Phys. Rev. B 68, 205324 (2003).
- [6] M.J.M ontgom ery, J.H oekstra, T.N. Todorov, and A.P. Sutton, J. of Phys. C ond. M at. 15, 731 (2003).
- [7] Y. Chen, M. Zwolak, and M. DiVentra, Nano Lett. 4, 1709 (2004).
- [8] M. Galperin, M. A. Ratner, and A. Nitzan, Nano Lett. 4, 1605 (2004).
- [9] T. Frederiksen, M. Brandbyge, N. Lorente, and A.P. Jauho, Phys. Rev. Lett. 93, 256601 (2004).

- [10] T.M ii, S.G. Tikhodeev, and H.Ueba, Phys. Rev. B 68, 205406 (2003).
- [11] B. N. J. Persson and M. Persson, Surf. Sci. 97, 609 (1980).
- [12] H.Haug and A.P.Jauho, Quantum kinetics in transport and optics of sem iconductors (Springer-Verlag, Berlin, 1996).
- [13] A. Peochia and A. D. Carlo, Rep. Prog. Phys. 67, 1497 (2004).
- [14] M .Head-Gordon and J.C.Tully, J.ofChem .Phys.96, 3938 (1992).
- [15] J.K. Viljas, J.C. Cuevas, F. Pauly, and M. Hafner, during the review process a preprint (cond-m at/0508470) using sim ilar approxim ations appeared.
- [16] D.D jukic, K.S.Thygesen, C.Untiedt, R.H.M.Sm it, K.W.Jacobsen, and J.M.van Ruitenbeek, Phys.Rev. B 71, 161402 (2005).
- [17] P. Hyldgaard, S. Hersh eld, J. H. Davies, and J. W. W ilkins, Annals of Physics 236, 1 (1994).
- [18] P.K.Hansma, Phys.Rep. 30, 145 (1977).